

TXS0108E 8-Bit Bidirectional Voltage-Level Translator for Open-Drain and Push-Pull Applications

1 Features

- No Direction-Control Signal Needed
- Max Data Rates
 - 60 Mbps (Push Pull)
 - 2 Mbps (Open Drain)
- 1.2 V to 3.6 V on A Port and 1.65 V to 5.5 V on B Port ($V_{CCA} \leq V_{CCB}$)
- No Power-Supply Sequencing Required – Either V_{CCA} or V_{CCB} Can Be Ramped First
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22 (A Port)
 - 2000-V Human Body Model (A114-B)
 - 150-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- IEC 61000-4-2 ESD (B Port)
 - ± 8 -kV Contact Discharge
 - ± 6 -kV Air-Gap Discharge

2 Applications

- Handsets
- Smartphones
- Tablets
- Desktop PCs

3 Description

This 8-bit noninverting translator uses two separate configurable power-supply rails. The A port is designed to track V_{CCA} . V_{CCA} accepts any supply voltage from 1.2 V to 3.6 V. The B port is designed to track V_{CCB} . V_{CCB} accepts any supply voltage from 1.65 V to 5.5 V. This allows for low-voltage bidirectional translation between any of the 1.2-V, 1.5-V, 1.8-V, 2.5-V, 3.3-V, and 5-V voltage nodes.

When the output-enable (OE) input is low, all outputs are placed in the high-impedance (Hi-Z) state.

To ensure the Hi-Z state during power up or power down, OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TXS0108E	TSSOP (20)	6.50 mm × 6.40 mm
	VQFN (20)	4.50 mm × 3.50 mm
	UFBGA (20)	3.00 mm × 2.50 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Typical Application Block Diagram for TXS010x

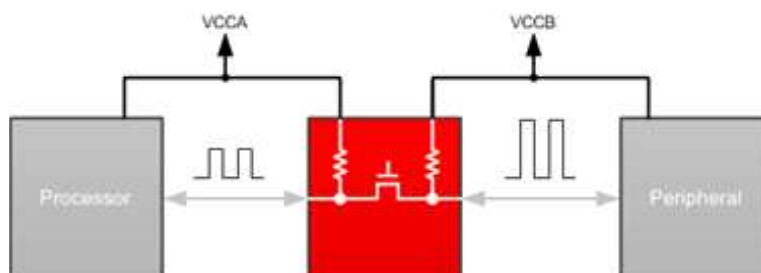


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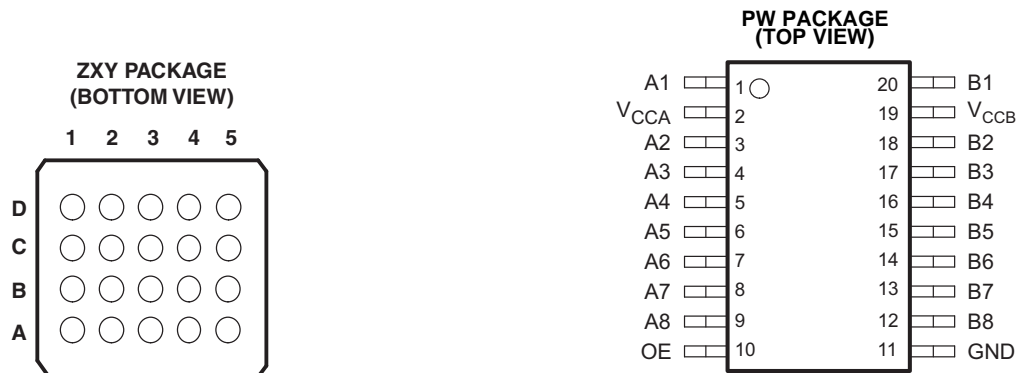
4 Revision History

Changes from Revision B (November 2013) to Revision C

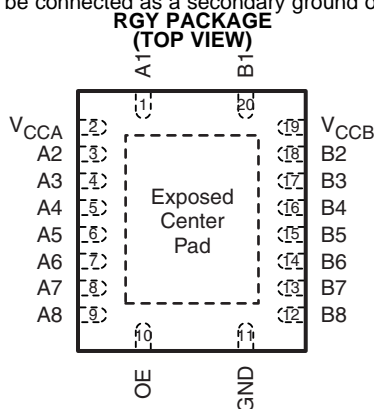
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- Added *Pin Configuration and Functions* section, *ESD Ratings* table, *Feature Description* section, *Device Functional Modes*, *Application and Implementation* section, *Power Supply Recommendations* section, *Layout* section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* section **1**

5 Pin Configuration and Functions



The exposed center pad, if used, must be connected as a secondary ground or left electrically open.



Pin Assignments

	1	2	3	4	5
D	V _{CCB}	B2	B4	B6	B8
C	B1	B3	B5	B7	GND
B	A1	A3	A5	A7	OE
A	V _{CCA}	A2	A4	A6	A8

Pin Functions

PIN			TYPE	DESCRIPTION
NAME	PW, RGY NO.	ZXY NO.		
A1	1	B1	I/O	Input/output 1. Referenced to V _{CCA}
V _{CCA}	2	A1	S	A-port supply voltage. 1.2 V ≤ V _{CCA} ≤ 3.6 V, V _{CCA} ≤ V _{CCB} .
A2	3	A2	I/O	Input/output 2. Referenced to V _{CCA}
A3	4	B2	I/O	Input/output 3. Referenced to V _{CCA}
A4	5	A3	I/O	Input/output 4. Referenced to V _{CCA}
A5	6	B3	I/O	Input/output 5. Referenced to V _{CCA}
A6	7	A4	I/O	Input/output 6. Referenced to V _{CCA}
A7	8	B4	I/O	Input/output 7. Referenced to V _{CCA}
A8	9	A5	I/O	Input/output 8. Referenced to V _{CCA}
OE	10	B5	I	3-state output-mode enable. Pull OE low to place all outputs in 3-state mode. Referenced to V _{CCA} .
GND	11	C5	S	Ground
B8	12	D5	I/O	Input/output 8. Referenced to V _{CCB}

Pin Functions (continued)

PIN			TYPE	DESCRIPTION
NAME	PW, RGY NO.	ZXY NO.		
B7	13	C4	I/O	Input/output 7. Referenced to V_{CCB}
B6	14	D4	I/O	Input/output 6. Referenced to V_{CCB}
B5	15	C3	I/O	Input/output 5. Referenced to V_{CCB}
B4	16	D3	I/O	Input/output 4. Referenced to V_{CCB}
B3	17	C2	I/O	Input/output 3. Referenced to V_{CCB}
B2	18	D2	I/O	Input/output 2. Referenced to V_{CCB}
V_{CCA}	19	D1	S	B-port supply voltage. $1.65\text{ V} \leq V_{CCB} \leq 5.5\text{ V}$.
B1	20	C 1	I/O	Input/output 1. Referenced to V_{CCB}
Thermal Pad	—	—	—	For the RGY package, the exposed center thermal pad must be connected to ground

6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CCA}	Supply voltage		−0.5	4.6	V
V_{CCB}			−0.5	5.5	V
V_I	Input voltage ⁽²⁾	A port	−0.5	4.6	V
		B port	−0.5	6.5	
V_O	Voltage range applied to any output in the high-impedance or power-off state ⁽²⁾	A port	−0.5	4.6	V
		B port	−0.5	6.5	
V_O	Voltage range applied to any output in the high or low state ^{(2) (3)}	A port	−0.5	$V_{CCA} + 0.5$	V
		B port	−0.5	$V_{CCB} + 0.5$	
I_{IK}	Input clamp current	$V_I < 0$		−50	mA
I_{OK}	Output clamp current	$V_O < 0$		−50	mA
I_O	Continuous output current		−50	50	mA
	Continuous current through V_{CCA} , V_{CCB} , or GND		−100	100	mA
T_{stg}	Storage temperature		−65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under [Recommended Operating Conditions](#) is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CCA} and V_{CCB} are provided in the recommended operating conditions table.

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000
		Machine model (MM)	±150

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾⁽²⁾

		V_{CCA}	V_{CCB}	MIN	MAX	UNIT
V_{CCA}	Supply voltage ⁽³⁾			1.2	3.6	V
V_{CCB}				1.65	5.5	
V_{IH}	High-level input voltage	A-Port I/Os	1.2 V to 1.95 V	1.65 V to 5.5 V	$V_{CCI} - 0.2$	V
			1.95 V to 3.6 V		$V_{CCI} - 0.4$	
		B-Port I/Os	1.2 V to 3.6 V	1.65 V to 5.5 V	$V_{CCI} - 0.4$	
		OE			$V_{CCA} \times 0.65$	
V_{IL}	Low-level input voltage	A-Port I/Os	1.2 V to 1.95 V	1.65 V to 5.5 V	0	V
			1.95 V to 3.6 V		0	
		B-Port I/Os	1.2 V to 3.6 V	1.65 V to 5.5 V	0	
		OE			0 $V_{CCA} \times 0.35$	
$\Delta t/\Delta v$	Input transition rise or fall rate	A-Port I/Os push-pull driving	1.2 V to 3.6 V	1.65 V to 5.5 V	10	ns/V
		B-Port I/Os push-pull driving				
		Control input				
T_A	Operating free-air temperature			-40	85	°C

(1) V_{CCI} is the V_{CC} associated with the data input port.

(2) V_{CCO} is the V_{CC} associated with the output port.

(3) V_{CCA} must be less than or equal to V_{CCB} , and V_{CCA} must not exceed 3.6 V.

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TXS0108E			UNIT
		PW	RGY	ZXY	
		20 PINS	20 PINS	20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	101.5	34.7	101.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	35.9	39.5	35.9	
$R_{\theta JB}$	Junction-to-board thermal resistance	52.4	12.7	52.4	
Ψ_{JT}	Junction-to-top characterization parameter	2.3	0.9	2.3	
Ψ_{JB}	Junction-to-board characterization parameter	51.9	12.7	51.9	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	7.5	—	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

6.5 Electrical Characteristics⁽¹⁾⁽²⁾⁽³⁾

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CCA}	V _{CCB}	T _A = 25°C			–40°C to 85°C		UNIT
					MIN	TYP	MAX	MIN	MAX	
V _{OHA}		I _{OH} = –20 μA, V _{IB} ≥ V _{CCB} – 0.4 V	1.2 V 1.4 V to 3.6 V	1.65 V to 5.5 V	V _{CCA} × 0.67			V _{CCA} × 0.67		V
V _{OLA}		I _{OL} = 135 μA, V _{IB} ≤ 0.15 V	1.2 V	1.65 V to 5.5 V	0.25					V
		I _{OL} = 180 μA, V _{IB} ≤ 0.15 V	1.4 V					0.4		
		I _{OL} = 220 μA, V _{IB} ≤ 0.15 V	1.65 V					0.4		
		I _{OL} = 300 μA, V _{IB} ≤ 0.15 V	2.3 V					0.4		
		I _{OL} = 400 μA, V _{IB} ≤ 0.15 V	3 V					0.55		
V _{OHB}		I _{OH} = –20 μA, V _{IA} ≥ V _{CCA} – 0.2 V	1.2 V 1.4 V to 3.6 V	1.65 V to 5.5 V	V _{CCB} × 0.67			V _{CCB} × 0.67		V
V _{OLB}		I _{OL} = 220 μA, V _{IA} ≤ 0.15 V I _{OL} = 300 μA, V _{IA} ≤ 0.15 V I _{OL} = 400 μA, V _{IA} ≤ 0.15 V I _{OL} = 620 μA, V _{IA} ≤ 0.15 V	1.2 V to 3.6 V	1.65 V				0.4		V
				2.3 V				0.4		
				3 V				0.55		
				4.5 V				0.55		
I _I	OE	V _I = V _{CCI} or GND	1.2 V	1.65 V to 5.5 V	–1	1	2		μA	
I _{OZ}	A or B port		1.2 V	1.65 V to 5.5 V	–1	1	–2	2	μA	
I _{CCA}		V _I = V _O = Open, I _O = 0	1.2 V 1.4 V to 3.6 V 3.6 V 0 V	1.65 V to 5.5 V 2.3 V to 5.5 V 0 V 5.5 V	1.5			–2	2	μA
								2		
								2		
								–1		
I _{CCB}		V _I = V _O = Open, I _O = 0	1.2 V 1.4 V to 3.6 V 3.6 V 0 V	1.65 V to 5.5 V 2.3 V to 5.5 V 0 V 5.5 V	1.5					μA
								6		
								–1		
								1		
I _{CCA} + I _{CCB}		V _I = V _{CCI} or GND, I _O = 0	1.2 V 1.4 V to 3.6 V	2.3 V to 5.5 V	3					μA
						8				
I _{CCZA}		V _I = V _O = Open, I _O = 0, OE = GND	1.2 V 1.4 V to 3.6 V	1.65 V to 5.5 V	0.05					μA
						2				
I _{CCZB}		V _I = V _O = Open, I _O = 0, OE = GND	1.2 V 1.4 V to 3.6 V	1.65 V to 5.5 V	4					μA
						6				
C _i	OE		3.3 V	3.3 V	4.5			5.5		pF
C _{io}	A port		3.3 V	3.3 V	6			7		pF
	B port				5.5			6		

(1) V_{CCO} is the V_{CC} associated with the output port.

(2) V_{CCI} is the V_{CC} associated with the input port.

(3) V_{CCA} must be less than or equal to V_{CCB}, and V_{CCA} must not exceed 3.6 V.

6.6 Timing Requirements: $V_{CCA} = 1.2\text{ V}$

 $T_A = 25^\circ\text{C}$, $V_{CCA} = 1.2\text{ V}$

				$V_{CCB} = 1.8\text{ V}$	$V_{CCB} = 2.5\text{ V}$	$V_{CCB} = 3.3\text{ V}$	$V_{CCB} = 5\text{ V}$	UNIT
				TYP	TYP	TYP	TYP	
Data rate	Push-pull driving			20	20	20	20	Mbps
	Open-drain driving			2	2	2	2	
t_w Pulse duration	Push-pull driving	Data inputs	50	50	50	50	50	ns
			500	500	500	500	500	

6.7 Timing Requirements: $V_{CCA} = 1.5\text{ V} \pm 0.1\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 1.5\text{ V} \pm 0.1\text{ V}$ (unless otherwise noted)

				$V_{CC\ B} = 1.8\ V \pm 0.15\ V$		$V_{CC\ B} = 2.5\ V \pm 0.2\ V$		$V_{CC\ B} = 3.3\ V \pm 0.3\ V$		$V_{CC\ B} = 5\ V \pm 0.5\ V$		UNIT	
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
Data rate		Push-pull driving		40		60		60		50		Mbps	
		Open-drain driving		2		2		2		2			
t _w	Pulse duration	Push-pull driving		Data inputs	25		16.7		16.7		20		ns
		Open-drain driving			500		500		500		500		

6.8 Timing Requirements: $V_{CCA} = 1.8\text{ V} \pm 0.15\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 1.8\text{ V} \pm 0.15\text{ V}$ (unless otherwise noted)

				$V_{CC\ B} = 1.8\ V$ $\pm 0.15\ V$	$V_{CC\ B} = 2.5\ V$ $\pm 0.2\ V$	$V_{CC\ B} = 3.3\ V$ $\pm 0.3\ V$	$V_{CC\ B} = 5\ V$ $\pm 0.5\ V$	UNIT
				MIN	MAX	MIN	MAX	
Data rate		Push-pull driving		40	60	60	60	Mbps
		Open-drain driving		2	2	2	2	
t _w	Pulse duration	Push-pull driving	Data inputs	25	16.7	16.7	16.7	ns
		Open-drain driving		500	500	500	500	

6.9 Timing Requirements: $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted)

				$V_{CCB} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CC} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
Data rate	Push-pull driving			60	60	60	Mbps			
	Open-drain driving			2	2	2				
t_w	Pulse duration	Push-pull driving	Data inputs	16.7	16.7	16.7	ns			
		Open-drain driving		500	500	500				

6.10 Timing Requirements: $V_{CCA} = 3.3\text{ V} \pm 0.3\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 3.3\text{ V} \pm 0.3\text{ V}$ (unless otherwise noted)

			$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CC} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
			MIN	MAX	MIN	MAX	
Data rate	Push-pull driving		60		60		Mbps
	Open-drain driving		2		2		
t_w Pulse duration	Push-pull driving	Data inputs	16.7		16.7		ns
	Open-drain driving		500		500		

6.11 Switching Characteristics: $V_{CCA} = 1.2\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 1.2\text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	$V_{CCB} = 1.8\text{ V}$ $\pm 0.15\text{ V}$	$V_{CCB} = 2.5\text{ V}$ $\pm 0.2\text{ V}$	$V_{CCB} = 3.3\text{ V}$ $\pm 0.3\text{ V}$	$V_{CCB} = 5\text{ V}$ $\pm 0.5\text{ V}$	UNIT
				TYP	TYP	TYP	TYP	
t_{PHL}	A	B	Push-pull driving	6.5	5.9	5.7	5.5	ns
t_{PLH}			Open-drain driving	11.9	11.1	11.0	11.1	
			Push-pull driving	7.1	6.3	6.2	6.6	
			Open-drain driving	293	236	197	152	
t_{PHL}	B	A	Push-pull driving	6.4	6	5.8	5.6	ns
t_{PLH}			Open-drain driving	8.5	6.8	6.2	5.9	
			Push-pull driving	5.6	4.1	3.6	3.2	
			Open-drain driving	312	248	192	132	
t_{en}	OE	A or B	Push-pull driving	200	200	200	200	ns
t_{dis}	OE	A or B		16.8	13.9	13.2	13.5	ns
t_{rA}	A-port rise time		Push-pull driving	7.9	6.7	6.5	6.4	ns
			Open-drain driving	296	238	185	127	
t_{rB}	B-port rise time		Push-pull driving	6.3	3.3	1.8	1.5	ns
			Open-drain driving	236	164	115	60	
t_{fA}	A-port fall time		Push-pull driving	5.8	4.8	4.3	3.8	ns
			Open-drain driving	5.9	4.7	4.1	3.5	
t_{fB}	B-port fall time		Push-pull driving	4.6	2.8	2.2	1.9	
			Open-drain driving	4.5	2.7	2.2	1.9	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving	1	1	1	1	ns
Max data rate	A or B		Push-pull driving	20	20	20	20	Mbps
			Open-drain driving	2	2	2	2	

6.12 Switching Characteristics: $V_{CCA} = 1.5\text{ V} \pm 0.1\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 1.5\text{ V} \pm 0.1\text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	$V_{CCB} = 1.8\text{ V}$ $\pm 0.15\text{ V}$		$V_{CCB} = 2.5\text{ V}$ $\pm 0.2\text{ V}$		$V_{CCB} = 3.3\text{ V}$ $\pm 0.3\text{ V}$		$V_{CCB} = 5\text{ V}$ $\pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull driving	11		9.2		8.6		8.6		ns
t_{PLH}			Open-drain driving	4	14.4	3.6	12.8	3.5	12.2	3.5	12	
			Push-pull driving	12		10		9.8		9.7		
			Open-drain driving	182	720	143	554	114	473	81	384	
t_{PHL}	B	A	Push-pull driving	12.7		11.1		11		12		ns
t_{PLH}			Open-drain driving	3.4	13.2	3.1	9.6	2.8	8.5	2.5	7.5	
			Push-pull driving	9.5		6.2		5.1		1.6		
			Open-drain driving	186	745	147	603	118	519	84	407	
t_{en}	OE	A or B	Push-pull driving	200		200		200		200		ns
t_{dis}	OE	A or B		28.1		22		20.1		19.6		ns
t_{rA}	A-port rise time		Push-pull driving	3.5	13.1	3	9.8	3.1	9	3.2	8.3	ns
			Open-drain driving	147	982	115	716	92	592	66	481	
t_{rB}	B-port rise time		Push-pull driving	2.9	11.4	1.9	7.4	0.9	4.7	0.7	2.6	ns
			Open-drain driving	135	1020	91	756	58	653	20	370	

Switching Characteristics: $V_{CCA} = 1.5\text{ V} \pm 0.1\text{ V}$ (continued)

over recommended operating free-air temperature range, $V_{CCA} = 1.5\text{ V} \pm 0.1\text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	$V_{CCB} = 1.8\text{ V} \pm 0.15\text{ V}$		$V_{CCB} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CCB} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t_{fA}	A-port fall time		Push-pull driving	2.3	9.9	1.7	7.7	1.6	6.8	1.7	6	ns
			Open-drain driving	2.4	10	2.1	7.9	1.7	7	1.5	6.2	
t_{fB}	B-port fall time		Push-pull driving	2	8.7	1.3	5.5	0.9	3.8	0.8	3.1	
			Open-drain driving	1.2	11.5	1.3	8.6	1	9.6	0.5	7.7	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving		1	1	1		1.1		1	ns
Max data rate	A or B		Push-pull driving	40		60		60		50		Mbps
			Open-drain driving	2		2		2		2		

6.13 Switching Characteristics: $V_{CCA} = 1.8\text{ V} \pm 0.15\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 1.8\text{ V} \pm 0.15\text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V _{CCB} = 1.8 V ± 0.15 V		V _{CCB} = 2.5 V ± 0.2 V		V _{CCB} = 3.3 V ± 0.3 V		V _{CCB} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _{PHL}	A	B	Push-pull driving	8.2		6.4		5.7		5.6		ns
t _{PLH}			Open-drain driving	3.6	11.4	3.2	9.9	3.1	9.3	3.1	8.9	
			Push-pull driving	9		2.1		6.5		6.3		
			Open-drain driving	194	729	155	584	126	466	90	346	
t _{PHL}	B	A	Push-pull driving	9.8		8		7.4		7		ns
t _{PLH}			Open-drain driving	3.4	12.1	2.8	8.5	2.5	7.3	2.1	6.2	
			Push-pull driving	10.2		7		5.8		5		
			Open-drain driving	197	733	159	578	129	459	93	323	
t _{en}	OE	A or B	Push-pull driving	200		200		200		200		ns
t _{dis}	OE	A or B		25.1		18.8		16.5		15.3		ns
t _{rA}	A-port rise time		Push-pull driving	3.1	11.9	2.6	8.6	2.7	7.8	2.8	7.2	ns
			Open-drain driving	155	996	124	691	100	508	72	350	
t _{rB}	B-port rise time		Push-pull driving	2.8	10.5	1.8	7.2	1.2	5.2	0.7	2.7	ns
			Open-drain driving	132	1001	106	677	73	546	32	323	
t _{fA}	A-port fall time		Push-pull driving	2.1	8.8	1.6	6.6	1.4	5.7	1.4	4.9	ns
			Open-drain driving	2.2	9	1.7	6.7	1.4	5.8	1.2	5.2	
t _{fB}	B-port fall time		Push-pull driving	2	8.3	1.3	5.4	0.9	3.9	0.7	3	
			Open-drain driving	0.8	10.5	0.7	10.7	1	9.6	0.6	7.8	
t _{SK(O)}	Channel-to-channel skew		Push-pull driving	1		1		1		1		ns
Max data rate	A or B		Push-pull driving	40		60		60		60		Mbps
			Open-drain driving	2		2		2		2		

6.14 Switching Characteristics: $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	$V_{CCB} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CCB} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull driving	5		4		3.7		ns
			Open-drain driving	2.4	6.9	2.3	6.3	2.2	5.8	
t_{PLH}			Push-pull driving	5.2		4.3		3.9		
			Open-drain driving	149	592	125	488	93	368	

Switching Characteristics: $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$ (continued)

over recommended operating free-air temperature range, $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	$V_{CCB} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CCB} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t_{PHL}	B	A	Push-pull driving		5.4		4.7		4.2	ns
			Open-drain driving	2.5	7.3	2.2	6	1.8	4.9	
t_{PLH}			Push-pull driving		5.9		4.4		3.5	
			Open-drain driving	150	595	126	481	94	345	
t_{en}	OE	A or B	Push-pull driving		200		200		200	ns
t_{dis}	OE	A or B			15.7		12.9		11.2	ns
t_{rA}	A-port rise time		Push-pull driving	2	7.3	2.1	6.4	2.2	5.8	ns
			Open-drain driving	110	692	93	529	68	369	
t_{rB}	B-port rise time		Push-pull driving	1.8	6.5	1.3	5.1	0.7	3.4	ns
			Open-drain driving	107	693	79	483	41	304	
t_{fA}	A-port fall time		Push-pull driving	1.5	5.7	1.2	4.7	1.3	3.8	ns
			Open-drain driving	1.5	5.6	1.2	4.7	1.1	4	
t_{fB}	B-port fall time		Push-pull driving	1.4	5.4	0.9	4.1	0.7	3	
			Open-drain driving	0.4	14.2	0.5	19.4	0.4	3	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving		1		1.2		1	ns
Max data rate	A or B		Push-pull driving		60		60		60	Mbps
			Open-drain driving		2		2		2	

6.15 Switching Characteristics: $V_{CCA} = 3.3\text{ V} \pm 0.3\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 3.3\text{ V} \pm 0.3\text{ V}$ (unless otherwise noted)

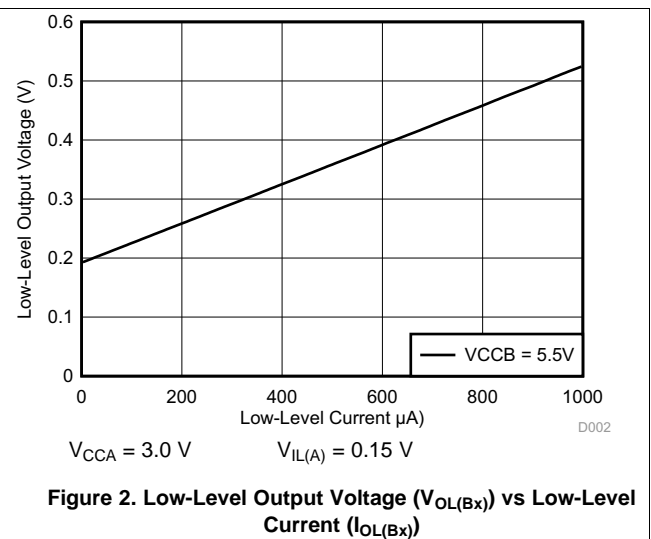
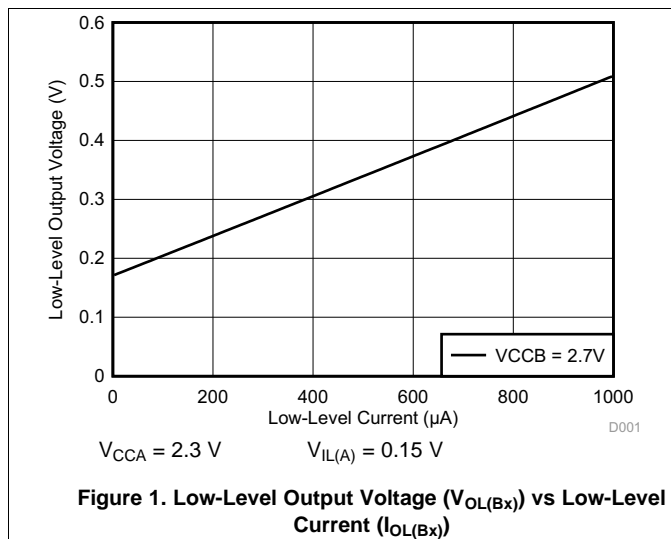
PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CCB} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull driving		3.8		3.1	ns
			Open-drain driving	2	5.3	1.9	4.8	
t_{PLH}			Push-pull driving		3.9		3.5	
			Open-drain driving	111	439	87	352	
t_{PHL}	B	A	Push-pull driving		4.2		3.8	ns
			Open-drain driving	2.1	5.5	1.7	4.5	
t_{PLH}			Push-pull driving		3.8		4.3	
			Open-drain driving	112	449	86	339	
t_{en}	OE	A or B	Push-pull driving		200		200	ns
t_{dis}	OE	A or B			11.9		9.8	ns
t_{rA}	A-port rise time		Push-pull driving	1.8	5.7	1.9	5	ns
			Open-drain driving	75	446	57	337	
t_{rB}	B-port rise time		Push-pull driving	1.5	5	1	3.6	ns
			Open-drain driving	72	427	40	290	
t_{fA}	A-port fall time		Push-pull driving	1.2	4.5	1.1	3.5	ns
			Open-drain driving	1.1	4.4	1	3.7	
t_{fB}	B-port fall time		Push-pull driving	1.1	4.2	0.8	3.1	
			Open-drain driving	1	4.2	0.8	3.1	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull driving		1		1	ns
Max data rate	A or B		Push-pull driving		60		60	Mbps
			Open-drain driving		2		2	

6.16 Operating Characteristics

$T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	V _{CCA}							UNIT
			1.2 V	1.2 V	1.5 V	1.8 V	2.5 V	2.5 V	3.3 V	
			V _{CCB}							
			5 V	1.8 V	1.8 V	1.8 V	2.5 V	5 V	3.3 V to 5 V	
			TYP	TYP	TYP	TYP	TYP	TYP	TYP	
C _{pdA}	A-port input, B-port output	C _L = 0, f = 10 MHz, t _r = t _f = 1 ns, OE = V _{CCA} (outputs enabled)	5.9	5.7	5.9	5.9	6.7	6.9	8	pF
	B-port input, A-port output		10.2	10.3	9.9	9.7	9.7	9.4	9.8	
C _{pdB}	A-port input, B-port output		29.9	22.2	21.5	20.8	21	23.4	23	
	B-port input, A-port output		22.9	16.7	16.7	16.8	17.8	20.8	20.9	
C _{pdA}	A-port input, B-port output	C _L = 0, f = 10 MHz, t _r = t _f = 1 ns, OE = GND (outputs disabled)	0.01	0.01	0.01	0.01	0.01	0.01	0.01	pF
	B-port input, A-port output		0.06	0.01	0.01	0.01	0.01	0.01	0.01	
C _{pdB}	A-port input, B-port output		0.06	0.01	0.01	0.01	0.01	0.03	0.02	
	B-port input, A-port output		0.06	0.01	0.01	0.01	0.01	0.03	0.02	

6.17 Typical Characteristics



Typical Characteristics (continued)

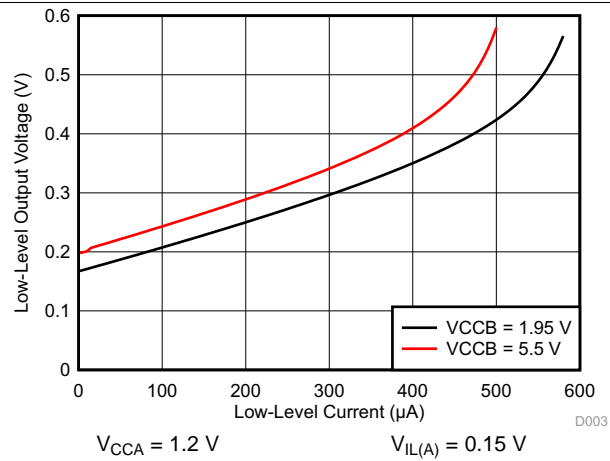
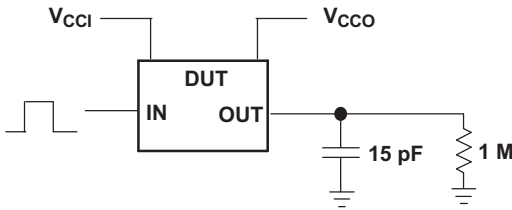
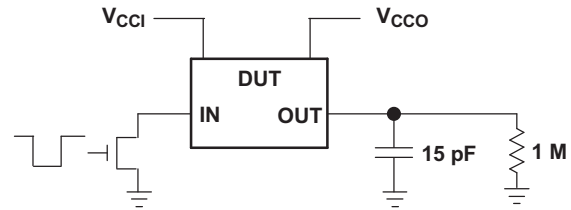


Figure 3. Low-Level Output Voltage ($V_{OL(Bx)}$) vs Low-Level Current ($I_{OL(Bx)}$)

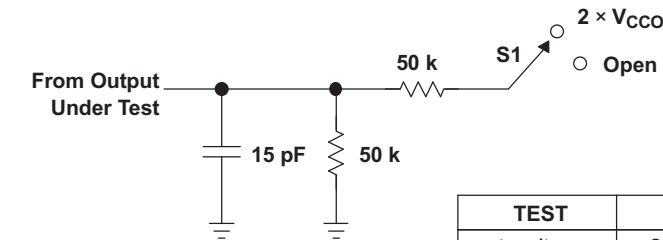
7 Parameter Measurement Information



DATA RATE, PULSE DURATION, PROPAGATION DELAY,
OUTPUT RISE AND FALL TIME MEASUREMENT USING
A PUSH-PULL DRIVER

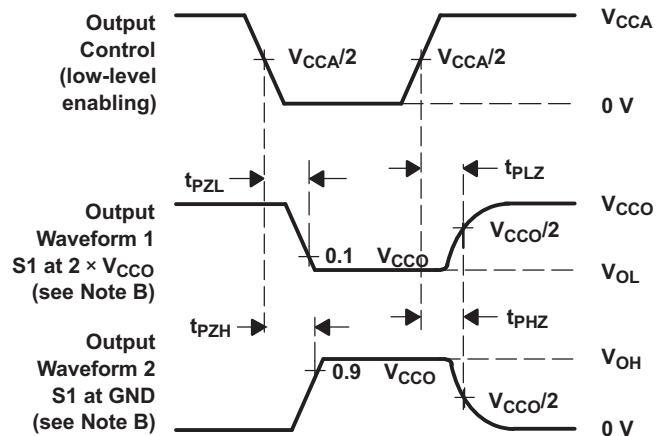
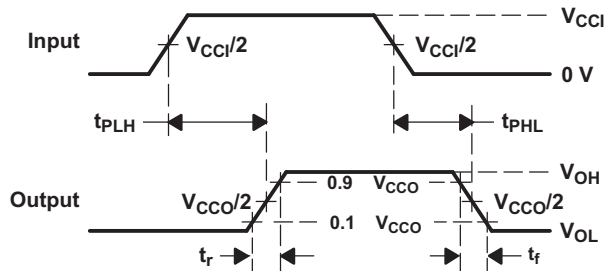
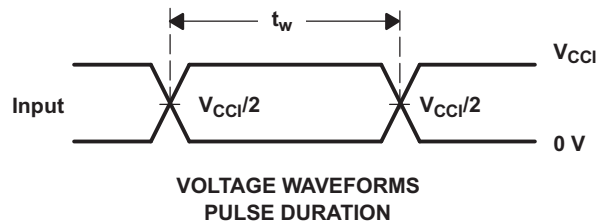


DATA RATE, PULSE DURATION, PROPAGATION DELAY,
OUTPUT RISE AND FALL TIME MEASUREMENT USING
AN OPEN-DRAIN DRIVER



LOAD CIRCUIT FOR ENABLE/DISABLE
TIME MEASUREMENT

TEST	S1
t_{PZL}/t_{PLZ}	$2 \times V_{CCO}$
t_{PHZ}/t_{PHZ}	Open



- C_L includes probe and jig capacitance.
- Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- All input pulses are supplied by generators having the following characteristics: PRR = 10 MHz, $Z_O = 50 \Omega$, $dv/dt \geq 1 \text{ V/ns}$.
- The outputs are measured one at a time, with one transition per measurement.
- t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- t_{PZL} and t_{PZH} are the same as t_{en} .
- t_{PLH} and t_{PHL} are the same as t_{pd} .
- V_{CCI} is the V_{CC} associated with the input port.
- V_{CCO} is the V_{CC} associated with the output port.
- All parameters and waveforms are not applicable to all devices.

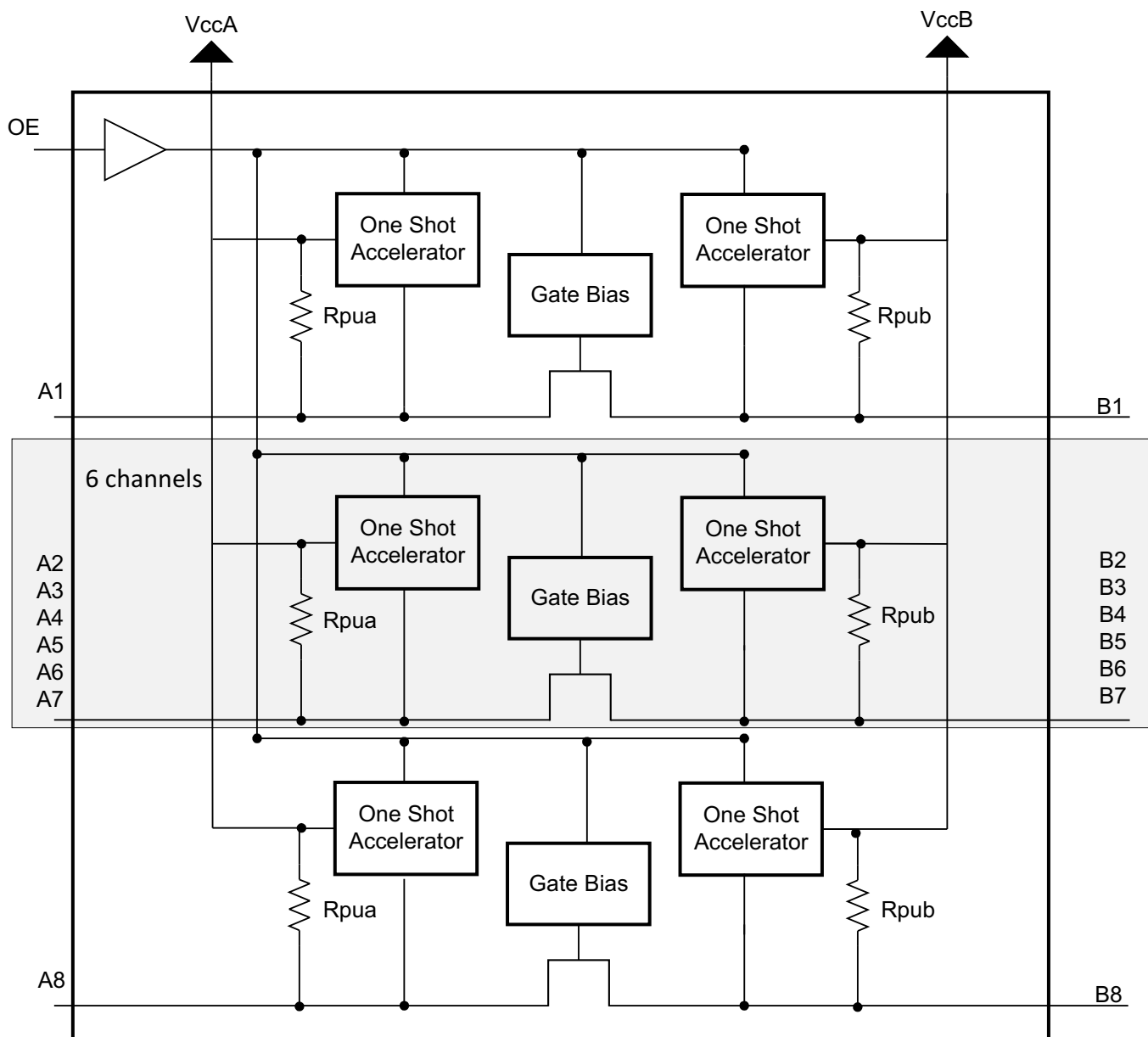
Figure 4. Load Circuit and Voltage Waveforms

8 Detailed Description

8.1 Overview

The TXS0108E device is a directionless voltage-level translator specifically designed for translating logic voltage levels. The A-port is able to accept I/O voltages ranging from 1.2 V to 3.6 V, while the B-port can accept I/O voltages from 1.65V to 5.5 V. The device is a pass gate architecture with edge rate accelerators (one shots) to improve the overall data rate. The pull-up resistors, commonly used in open-drain applications, have been conveniently integrated so that an external resistor is not needed. While this device is designed for open-drain applications, the device can also translate push-pull CMOS logic outputs.

8.2 Functional Block Diagram



Each A-port I/O has a pull-up resistor (R_{pua}) to V_{CCA} and each B-port I/O has a pull-up resistor (R_{pub}) to V_{CCB} . R_{pua} and R_{pub} have a value of 40 k Ω when the output is driving low. R_{pua} and R_{pub} have a value of 4 k Ω when the output is driving high. R_{pua} and R_{pub} are disabled when OE = Low.

8.3 Feature Description

8.3.1 Architecture

To address the application requirements for both push-pull and open-drain mode, a semi-buffered architecture design is used and is illustrated below (see Figure 5). Edge-rate accelerator circuitry (for both the high-to-low and low-to-high edges), a High-Ron n-channel pass-gate transistor (on the order of 300 Ω to 500 Ω) and pull-up resistors (to provide DC-bias and drive capabilities) are included to realize this solution. A direction-control signal (to control the direction of data flow from A to B or from B to A) is not needed. The resulting implementation supports both low-speed open-drain operation as well as high-speed push-pull operation.

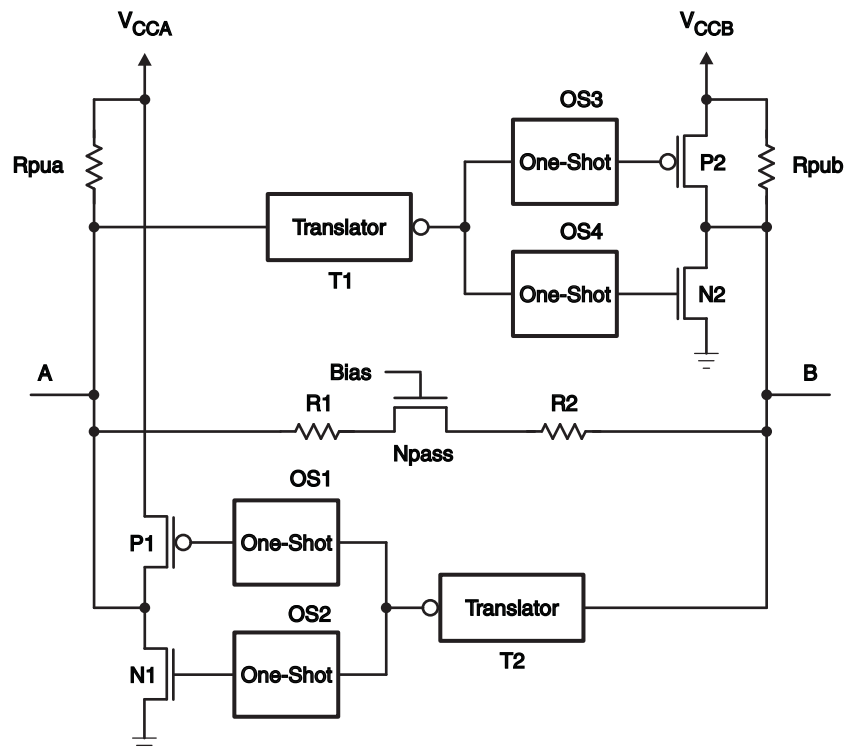


Figure 5. Architecture of a TXS0108 Cell

When transmitting data from A- to B-ports, during a rising edge the One-Shot (OS3) turns on the PMOS transistor (P2) for a short-duration and this speeds up the low-to-high transition. Similarly, during a falling edge, when transmitting data from A to B, the One-Shot (OS4) turns on NMOS transistor (N2) for a short-duration and this speeds up the high-to-low transition. The B-port edge-rate accelerator consists of one-shots OS3 and OS4, Transistors P2 and N2 and serves to rapidly force the B port high or low when a corresponding transition is detected on the A port.

When transmitting data from B- to A-ports, during a rising edge the One-Shot (OS1) turns on the PMOS transistor (P1) for a short-duration and this speeds up the low-to-high transition. Similarly, during a falling edge, when transmitting data from B to A, the One-Shot (OS2) turns on NMOS transistor (N1) for a short-duration and this speeds up the high-to-low transition. The A-port edge-rate accelerator consists of one-shots OS1 and OS2, transistors P1 and N1 components and form the edge-rate accelerator and serves to rapidly force the A port high or low when a corresponding transition is detected on the B port.

8.3.2 Input Driver Requirements

The continuous DC-current "sinking" capability is determined by the external system-level open-drain (or push-pull) drivers that are interfaced to the TXS0108E I/O pins. Because the high bandwidth of these bidirectional I/O circuits is used to facilitate this fast change from an input to an output and an output to an input, they have a modest DC-current "sourcing" capability of hundreds of micro-Amps, as determined by the internal pull-up resistors.

Feature Description (continued)

The fall time (t_{fA} , t_{fB}) of a signal depends on the edge-rate and output impedance of the external device driving TXS0108E data I/Os, as well as the capacitive loading on the data lines.

Similarly, the t_{pHL} and max data rates also depend on the output impedance of the external driver. The values for t_{fA} , t_{fB} , t_{pHL} , and maximum data rates in the data sheet assume that the output impedance of the external driver is less than 50 Ω .

8.3.3 Output Load Considerations

TI recommends careful PCB layout practices with short PCB trace lengths to avoid excessive capacitive loading and to ensure that proper O.S. triggering takes place. PCB signal trace-lengths should be kept short enough such that the round trip delay of any reflection is less than the one-shot duration. This improves signal integrity by ensuring that any reflection sees a low impedance at the driver. The O.S. circuits have been designed to stay on for approximately 30 ns. The maximum capacitance of the lumped load that can be driven also depends directly on the one-shot duration. With very heavy capacitive loads, the one-shot can time-out before the signal is driven fully to the positive rail. The O.S. duration has been set to best optimize trade-offs between dynamic ICC, load driving capability, and maximum bit-rate considerations. Both PCB trace length and connectors add to the capacitance of the TXS0108E output. Therefore, TI recommends that this lumped-load capacitance is considered in order to avoid O.S. retriggering, bus contention, output signal oscillations, or other adverse system-level affects.

8.3.4 Enable and Disable

The TXS0108E has an OE input that is used to disable the device by setting OE low, which places all I/Os in the Hi-Z state. The disable time (t_{dis}) indicates the delay between the time when OE goes low and when the outputs actually get disabled (Hi-Z). The enable time (t_{en}) indicates the amount of time the user must allow for the one-shot circuitry to become operational after OE is taken high.

8.3.5 Pull-up or Pulldown Resistors on I/O Lines

The TXS0108E has the smart pull-up resistors dynamically change value based on whether a low or a high is being passed through the I/O line. Each A-port I/O has a pull-up resistor (R_{pua}) to V_{CCA} and each B-port I/O has a pull-up resistor (R_{pub}) to V_{CCB} . R_{pua} and R_{pub} have a value of 40 k Ω when the output is driving low. R_{pua} and R_{pub} have a value of 4 k Ω when the output is driving high. R_{pua} and R_{pub} are disabled when OE = Low. This feature provides lower static power consumption (when the I/Os are passing a low), and supports lower V_{OL} values for the same size pass-gate transistor, and helps improve simultaneous switching performance.

8.4 Device Functional Modes

The TXS0108E device has two functional modes, enabled and disabled. To disable the device set the OE input low, which places all I/Os in a high impedance state. Setting the OE input high will enable the device.

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TXS0108E can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The TXS0108E is ideal for use in applications where an open-drain driver is connected to the data I/Os. The TXS0108E can also be used in applications where a push-pull driver is connected to the data I/Os, but the TXB0104 might be a better option for such push-pull applications. The TXS0108E device is a semi-buffered auto-direction-sensing voltage translator design is optimized for translation applications (for example, MMC Card Interfaces) that require the system to start out in a low-speed open-drain mode and then switch to a higher speed push-pull mode.

9.2 Typical Application

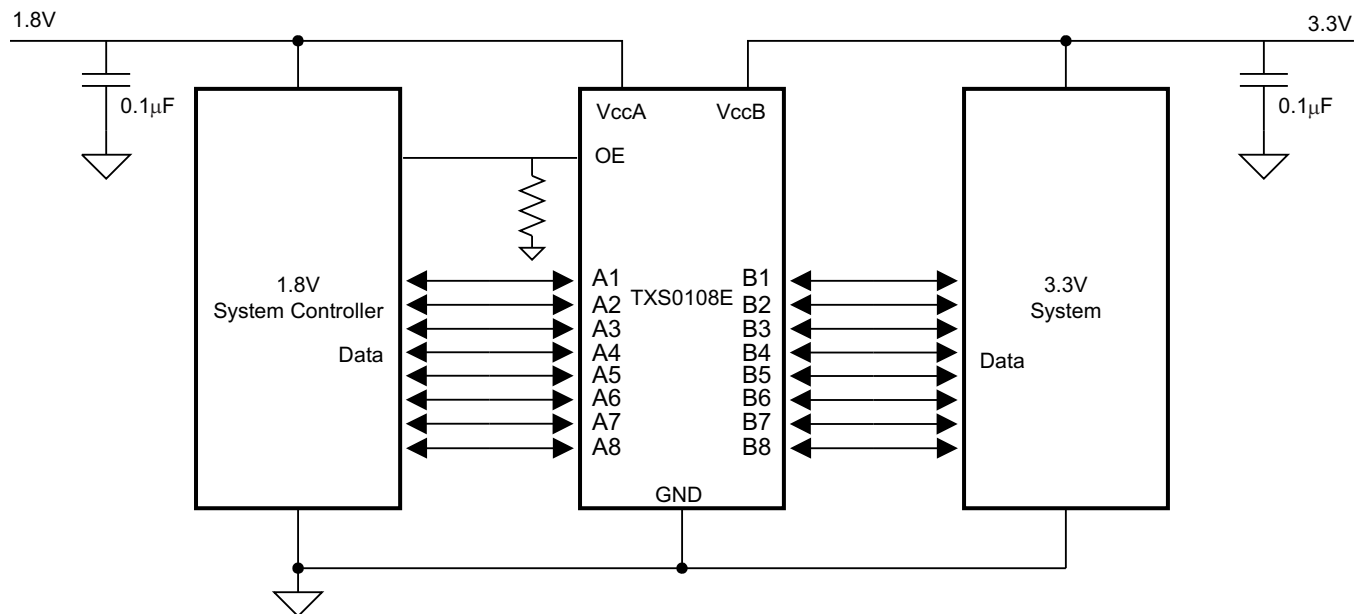


Figure 6. Typical Application Circuit

9.2.1 Design Requirements

For this design example, use the parameters listed in [Table 1](#). Make sure the $V_{CCA} \leq V_{CCB}$.

Table 1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range	1.2 V to 3.6 V
Output voltage range	1.65 V to 5.5 V

9.2.2 Detailed Design Procedure

To begin the design process, determine the following:

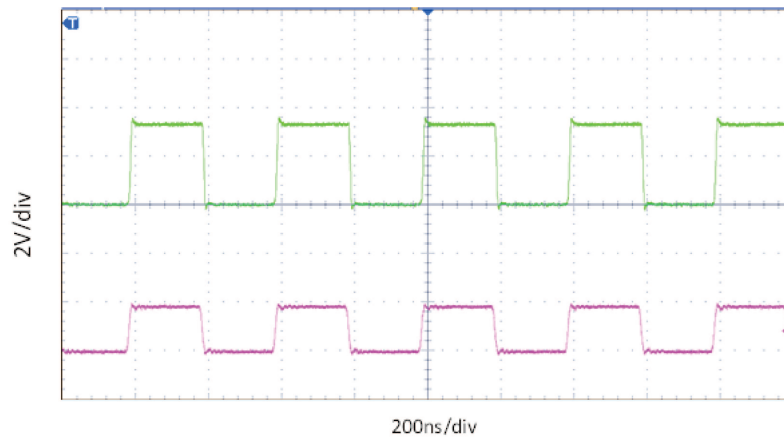
- Input voltage range
 - Use the supply voltage of the device that is driving the TXS0108E device to determine the input voltage range. For a valid logic high the value must exceed the V_{IH} of the input port. For a valid logic low the value

must be less than the V_{IL} of the input port.

- Output voltage range
 - Use the supply voltage of the device that the TXS0108E device is driving to determine the output voltage range.
 - The TXS0108E device has smart internal pull-up resistors. External pull-up resistors can be added to reduce the total RC of a signal trace if necessary.
- An external pulldown resistor decreases the output VOH and VOL. Use Equation 1 to calculate the VOH as a result of an external pulldown resistor.

$$V_{OH} = V_{CCX} \times R_{PD} / (R_{PD} + 4 \text{ k}\Omega) \quad (1)$$

9.2.3 Application Curves



$$V_{CCA} = 1.8 \text{ V}$$

$$V_{CCB} = 3.3 \text{ V}$$

Figure 7. Level-Translation of a 2.5-MHz Signal

10 Power Supply Recommendations

During operation, ensure that $V_{CCA} \leq V_{CCB}$ at all times. The sequencing of each power supply will not damage the device during the power up operation, so either power supply can be ramped up first. The output-enable (OE) input circuit is designed so that it is supplied by V_{CCA} and when the (OE) input is low, all outputs are placed in the high-impedance state. To ensure the high-impedance state of the outputs during power up or power down, the OE input pin must be tied to GND through a pulldown resistor and must not be enabled until V_{CCA} and V_{CCB} are fully ramped and stable. The minimum value of the pulldown resistor to ground is determined by the current-sourcing capability of the driver.

11 Layout

11.1 Layout Guidelines

To ensure reliability of the device, following common printed-circuit board layout guidelines is recommended.

- Bypass capacitors should be used on power supplies. Place the capacitors as close as possible to the VCCA, VCCB pin and GND pin.
- Short trace lengths should be used to avoid excessive loading.
- PCB signal trace-lengths must be kept short enough so that the round-trip delay of any reflection is less than the one shot duration, approximately 30 ns, ensuring that any reflection encounters low impedance at the source driver.

11.2 Layout Example

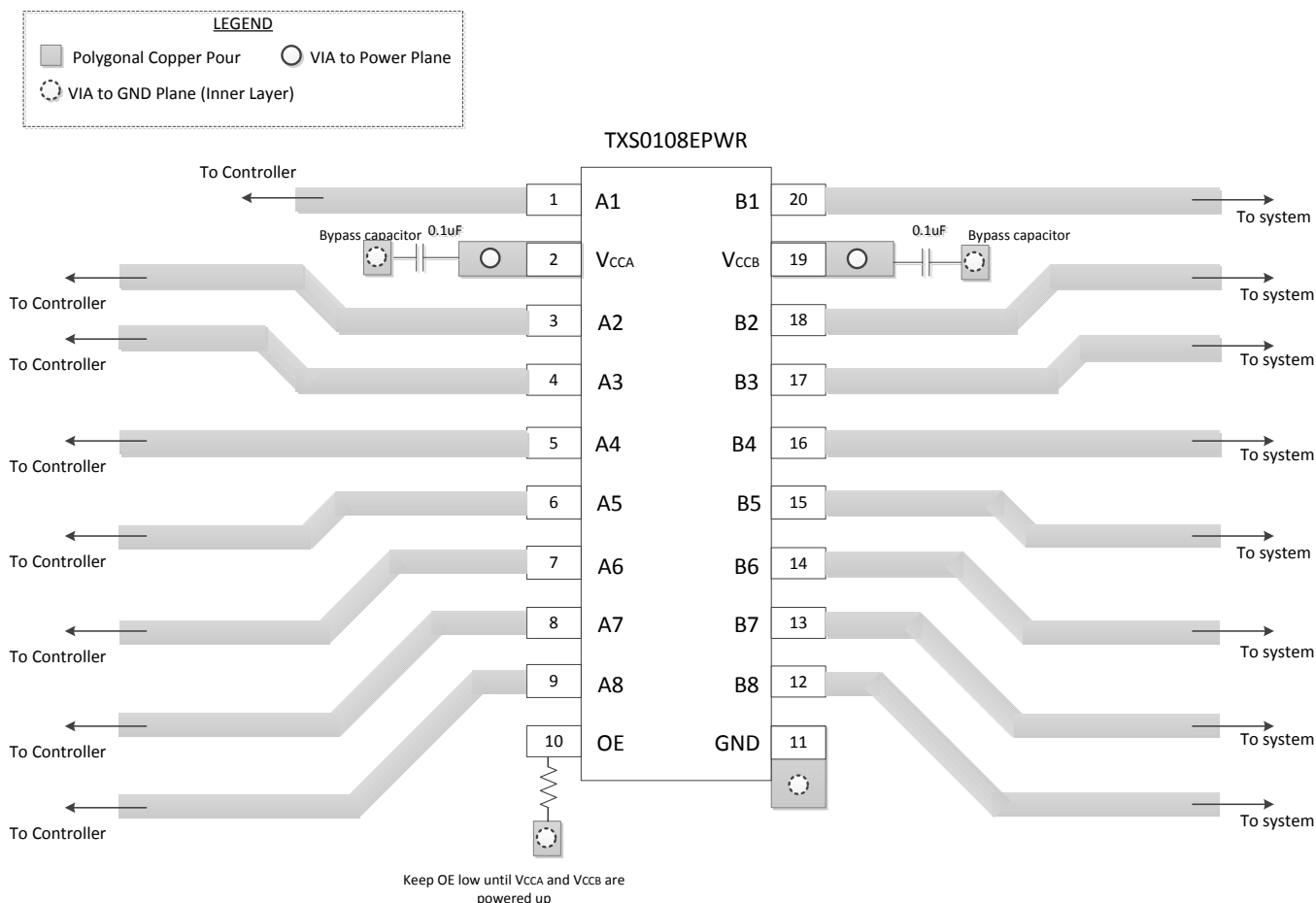


Figure 8. Layout Example

12 Device and Documentation Support

12.1 Trademarks

All trademarks are the property of their respective owners.

12.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.3 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TXS0108EPWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YF08E	Samples
TXS0108EPWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YF08E	Samples
TXS0108ERGYR	ACTIVE	VQFN	RGY	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YF08E	Samples
TXS0108EZXYR	ACTIVE	BGA MICROSTAR JUNIOR	ZXY	20	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	YF08E	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TXS0108EPWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
TXS0108ERGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1
TXS0108EZXYR	BGA MICROSTAR JUNIOR	ZXY	20	2500	330.0	12.4	2.8	3.3	1.0	4.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS

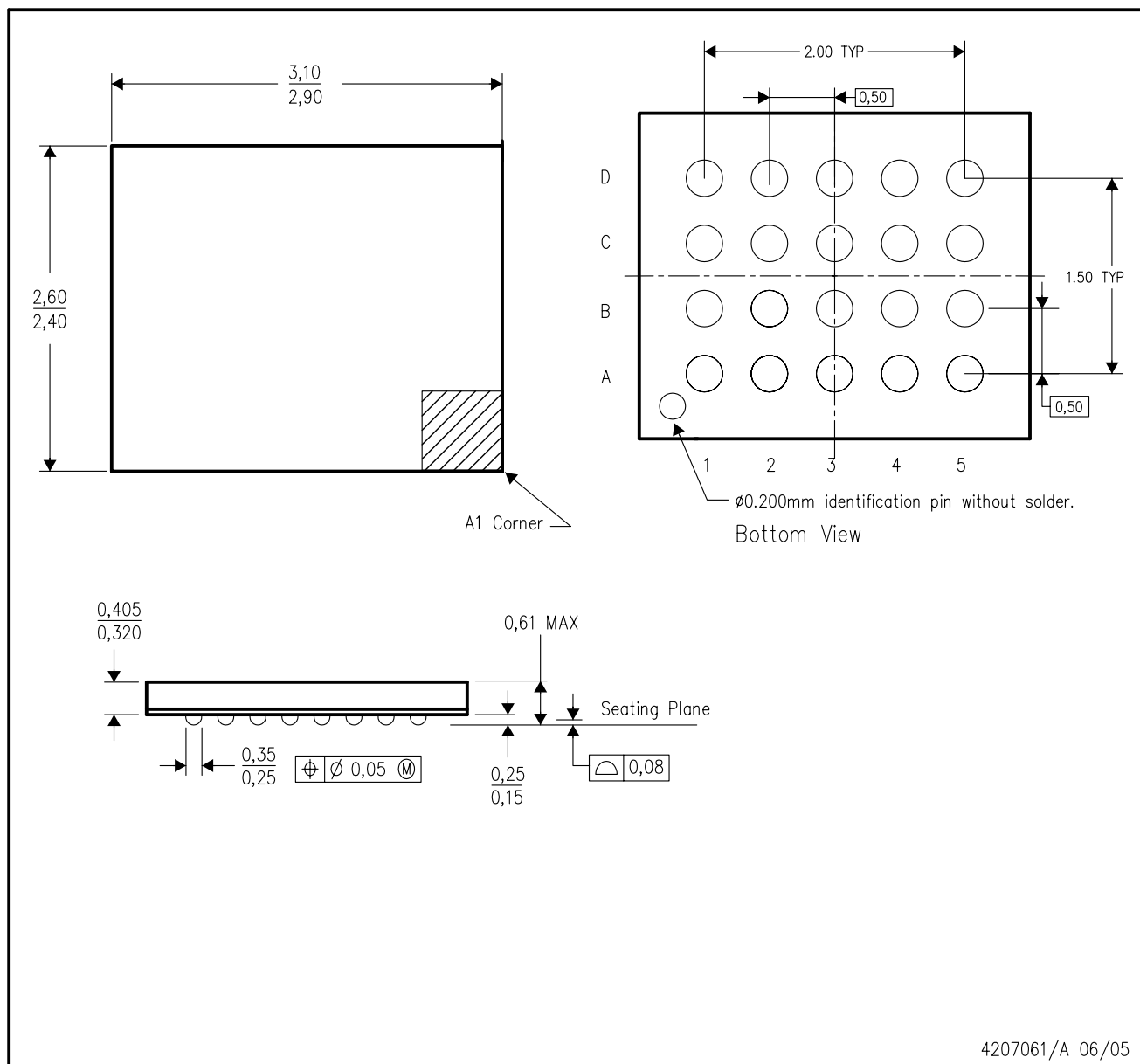


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TXS0108EPWR	TSSOP	PW	20	2000	367.0	367.0	38.0
TXS0108ERGYR	VQFN	RGY	20	3000	367.0	367.0	35.0
TXS0108EZXYR	BGA MICROSTAR JUNIOR	ZXY	20	2500	338.1	338.1	20.6

ZXY (S-PBGA-N20)

PLASTIC BALL GRID ARRAY



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. This package is a lead-free solder ball design.

PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



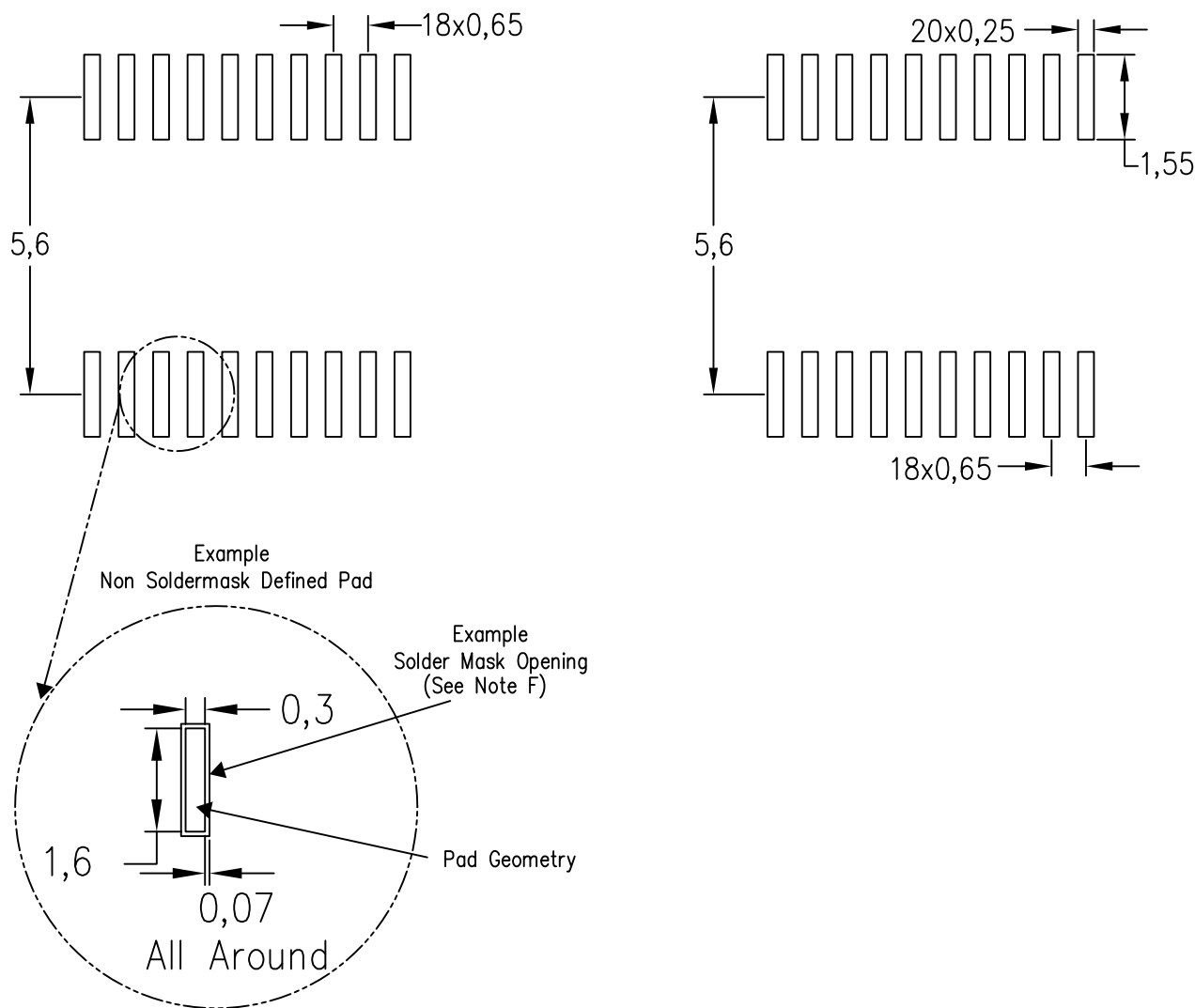
- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE

Example Board Layout

Based on a stencil thickness
of .127mm (.005inch).

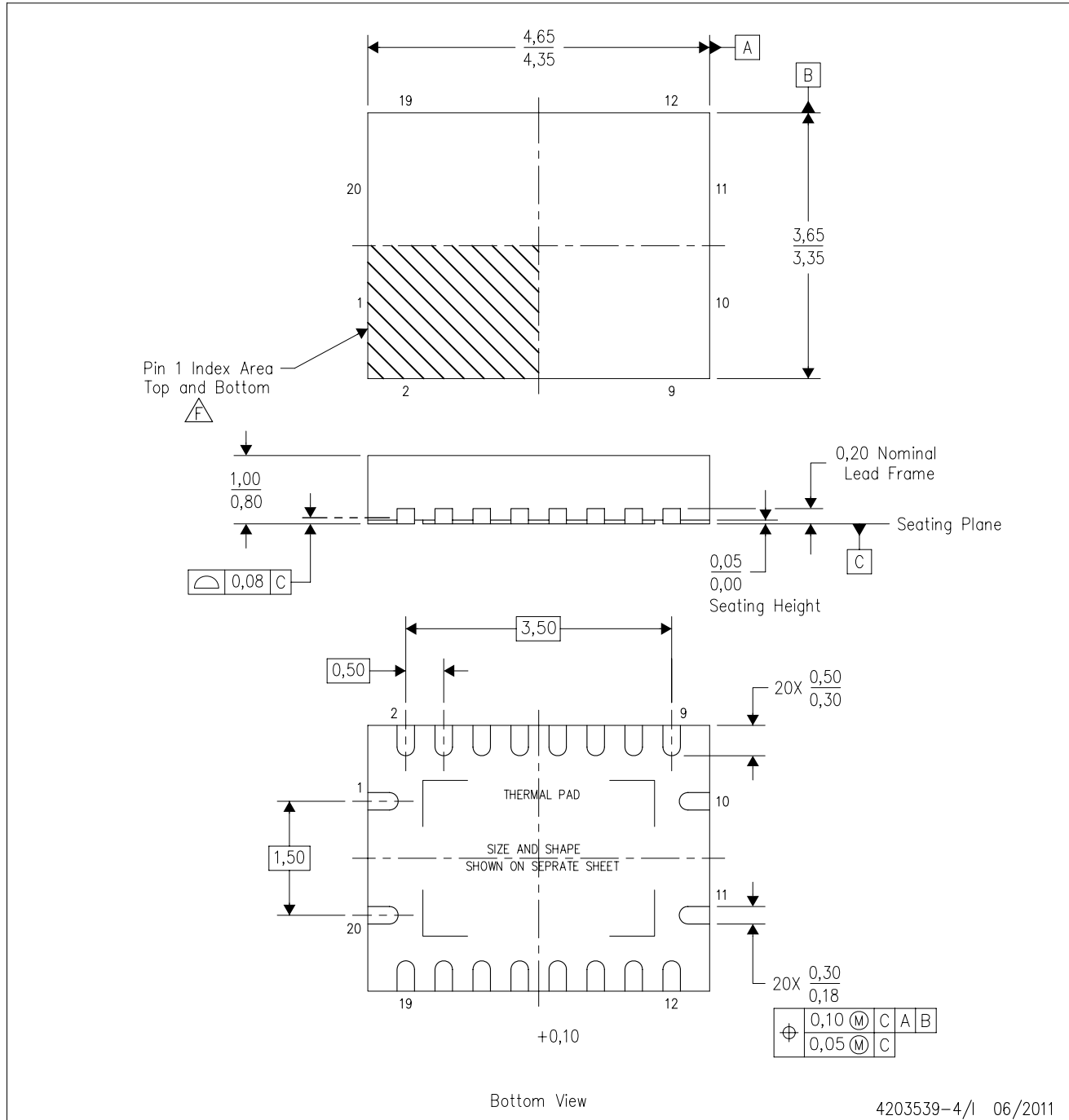


4211284-5/F 12/12

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate design.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

RGY (R-PVQFN-N20)

PLASTIC QUAD FLATPACK NO-LEAD



4203539-4/I 06/2011

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - QFN (Quad Flatpack No-Lead) package configuration.
 - The package thermal pad must be soldered to the board for thermal and mechanical performance.
 - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
 - Package complies to JEDEC MO-241 variation BA.

RGY (R-PVQFN-N20)

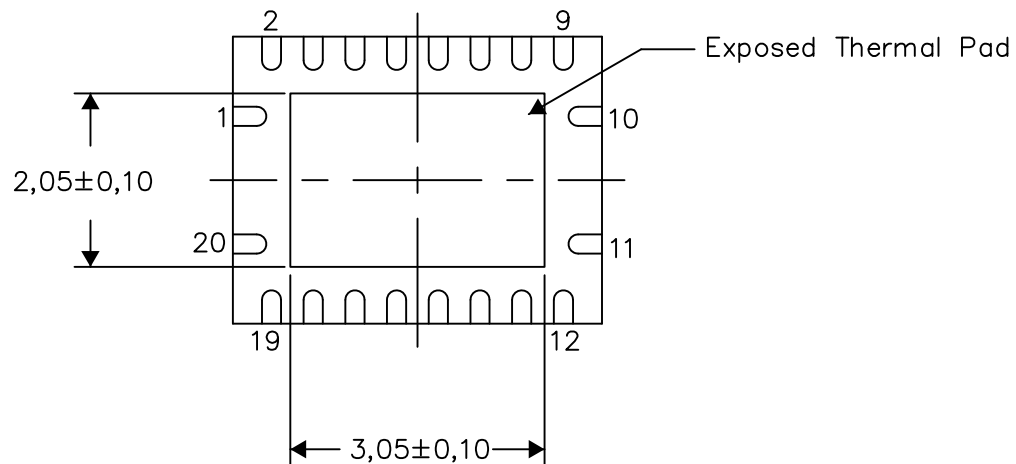
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

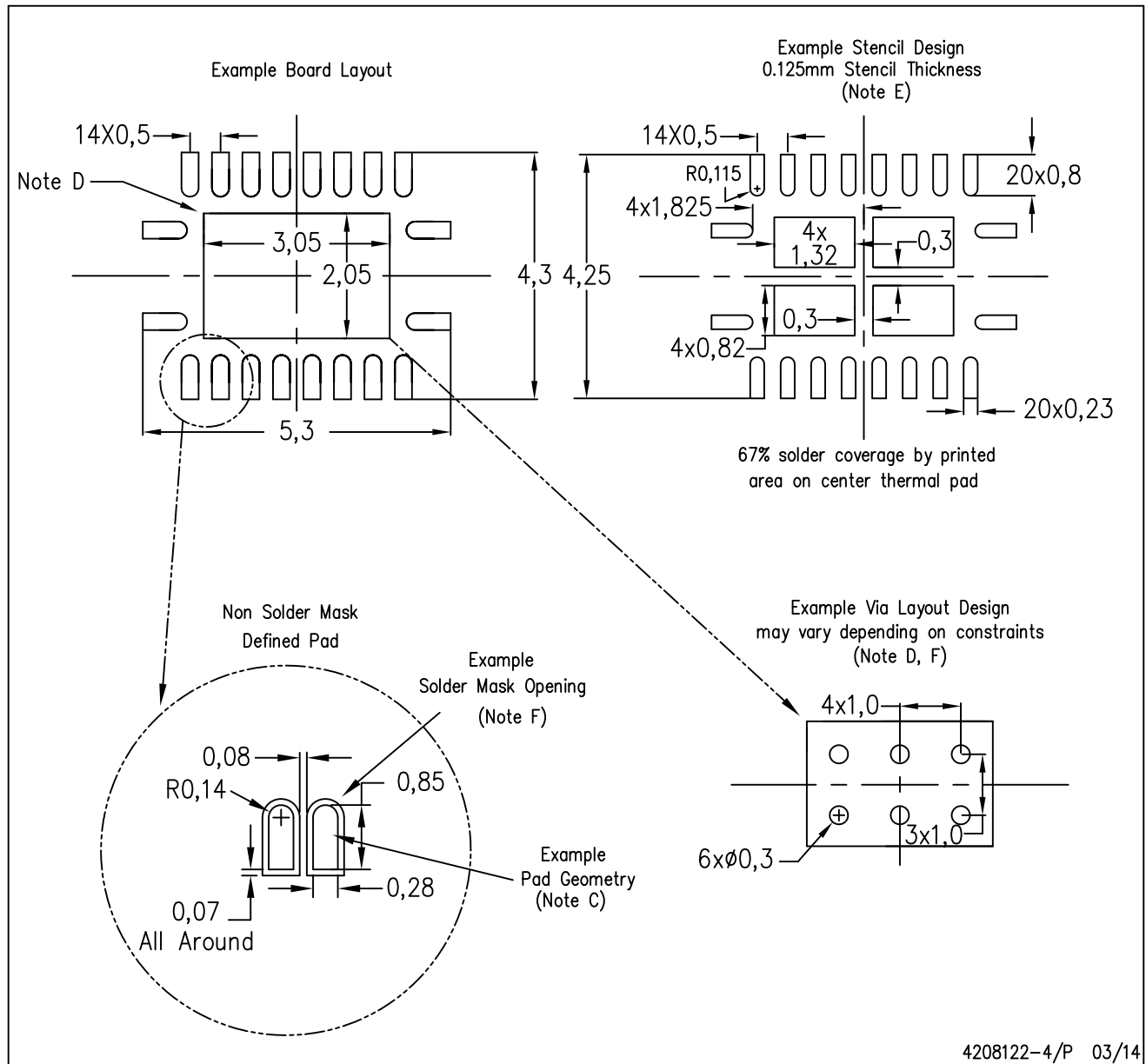
Exposed Thermal Pad Dimensions

4206353-4/P 03/14

NOTE: All linear dimensions are in millimeters

RGY (R-PVQFN-N20)

PLASTIC QUAD FLATPACK NO-LEAD



4208122-4/P 03/14

- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

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